



VMDSEMI

VSTD065R58ANB

Datasheet



VMDSEMI

General Description

$V_{(BR)DSS}$	$R_{DS(ON)_{max}}$	I_D
650V	580mΩ@10V	8A

Symbol

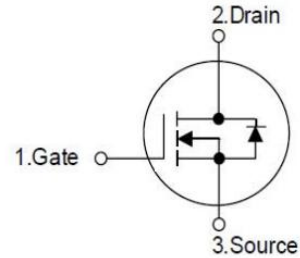


Figure 1 Symbol of VSTD065R58ANB

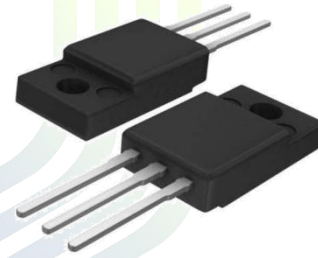
Features

- Low $R_{DS(ON)}$ & FOM
- Extremely low switching loss
- Excellent stability and uniformity

Application

- PC Power
- LED lighting
- Telecom Power
- Server Power
- EV Charger
- Solar/UPS

Package Type



TO-220F

Figure 2 Package Type of VSTD065R58ANB

VMDSEMI

Ordering Information

Product Name	Package
VSTD065R58ANB	TO-220F

Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DSS}	650	V
Gate-Source Voltage	V_{GSS}	±30	V
Continuous Drain Current ^{Note 1}	I_D	$T_C=25^{\circ}C$	8
Continuous Drain Current ^{Note 1}		$T_C=100^{\circ}C$	5
Pulsed Drain Current ^{Note 2}	$I_{D,pulse}$	$T_C=25^{\circ}C$	24
Continuous Diode Forward Current ^{Note 1}	I_S	$T_C=25^{\circ}C$	8
Diode Pulse Current ^{Note 2}	$I_{S,pulse}$	$T_C=25^{\circ}C$	24
Max Power Dissipation ^{Note 3}	P_D	$T_C=25^{\circ}C$	28
Avalanche Energy, Single Pulse ^{Note 5}	E_{AS}		150
MOSFET dv/dt ruggedness, $V_{DS}=0\dots480$ V	dv/dt		50
Reverse diode dv/dt, $V_{DS}=0\dots480$ V, $I_{SD}\leq I_D$	dv/dt		15
Operation and storage temperature	T_J, T_{STG}	-55 to 150	°C

Thermal Resistance

Parameter	Symbol	Min	Typ	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$		4.5		°C/W
Thermal Resistance, Junction-to-Ambient ^{Note 4}	$R_{\theta JA}$		62.5		

Notes:

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) P_D is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}C$.
- 5) $V_{DD}=50$ V, $V_{GS}=10$ V, $L=10.8$ mH, starting $T_J=25^{\circ}C$.

Electrical Characteristics($T_J=25\text{ }^\circ\text{C}$, unless otherwise specified)

Parameter		Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics							
Drain-Source Breakdown Voltage		BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	650			V
			$V_{GS}=0V, I_D=250\mu A, T_J=150\text{ }^\circ\text{C}$	700	750		V
Zero Gate Voltage Drain Current		I_{DSS}	$V_{DS}=650V, V_{GS}=0V$			1	μA
Gate-Body Leakage Current	Forward	I_{GSSF}	$V_{GS}=30V, V_{DS}=0V$			100	nA
	Reverse	I_{GSSR}	$V_{GS}=-30V, V_{DS}=0V$			-100	
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0		4.0	V
Drain-Source On-Resistance		$R_{DS(ON)}$	$V_{GS}=10V, I_D=4A$		0.52	0.58	Ω
Drain-Source On-Resistance $T_J=150\text{ }^\circ\text{C}$				1.27			
Gate resistance		R_G	f=1 MHz, Open drain		4.0		Ω
Dynamic Characteristics							
Input Capacitance		C_{ISS}	$V_{DS}=50V$		464		pF
Output Capacitance		C_{OSS}	$V_{GS}=0V$		38.3		pF
Reverse Transfer Capacitance		C_{RSS}	f=1MHz		1.47		pF
Turn-on Delay Time		$t_{d(on)}$	$V_{DS}=380V$		18		ns
Rise Time		t_r	$I_D=8A$		18		
Turn-off Delay Time		$t_{d(off)}$	$R_G=25\Omega$		27		
Fall Time		t_f	$V_{GS}=10V$		22		
Gate Charge Characteristics							
Gate to Source Charge		Q_{gs}	$V_{GS}=10V, V_{DS}=480V, I_D=8A$		2.7		nC
Gate to Drain Charge		Q_{gd}		3.8			
Gate Charge Total		Q_g		9.5			
Gate Plateau Voltage		$V_{plateau}$		5.6		V	
Reverse Diode Characteristics							
Drain-Source Diode Forward Voltage		V_{SD}	$V_{GS}=0V, I_S=8A$			1.3	V
Reverse Recovery Time		t_{rr}	$I_S=8A$		211		ns
Reverse Recovery Charge		Q_{rr}	$V_R=400V$		1.8		nC
Peak Reverse Recovery Current		I_{rrm}	di/dt=100A/us		10.5		A

Typical Performance Characteristics

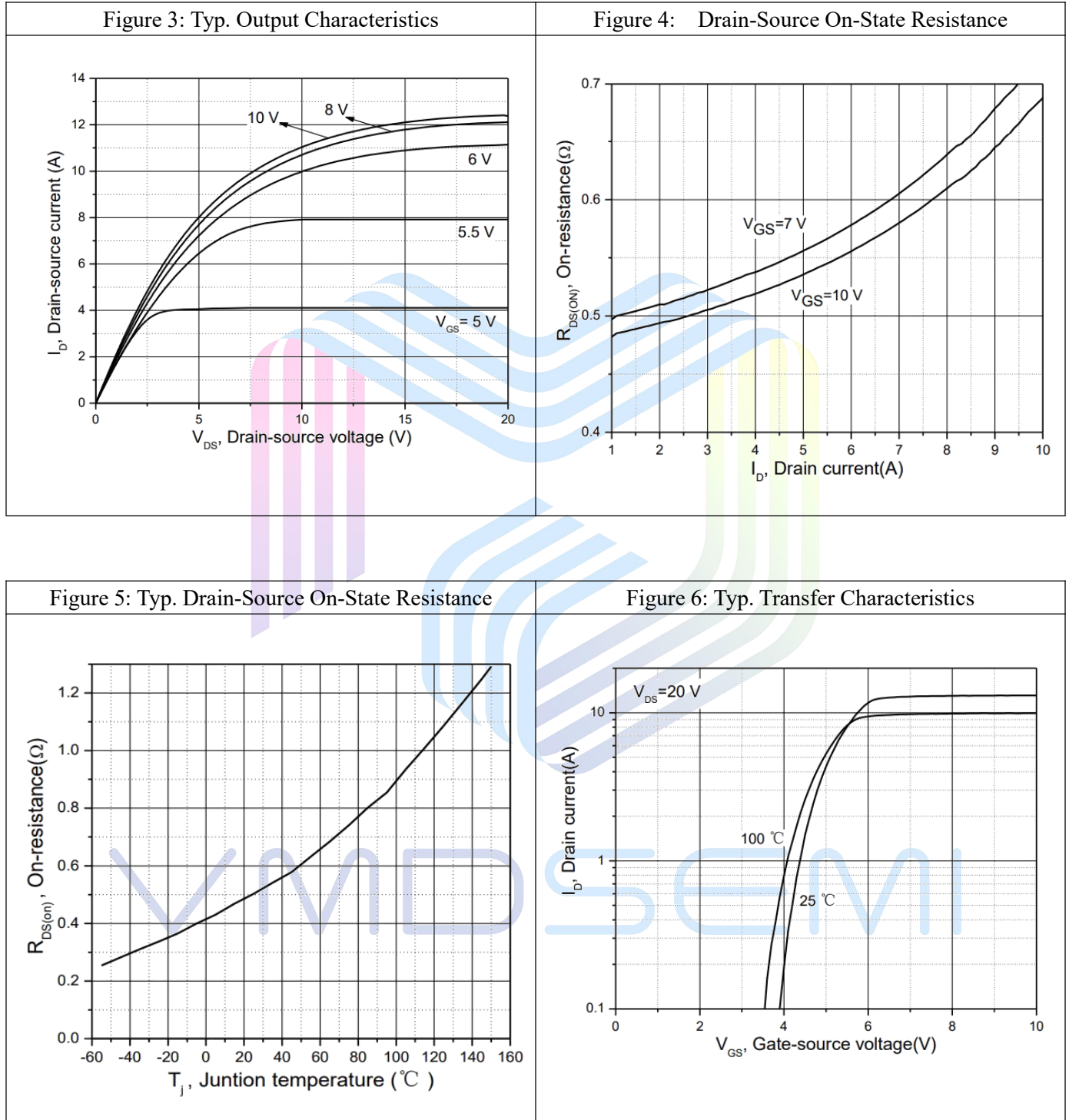


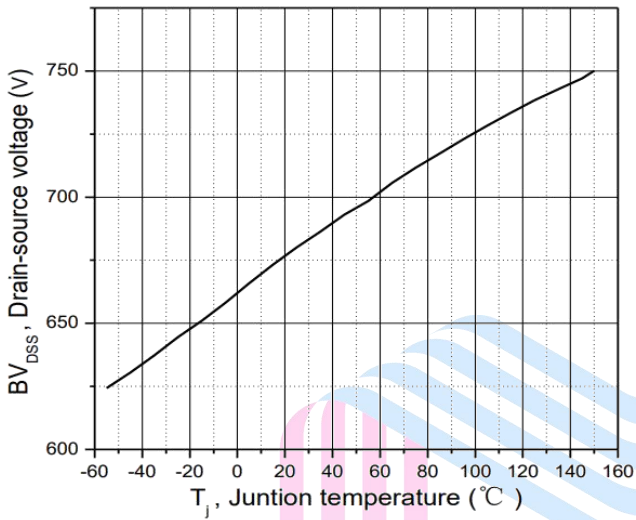
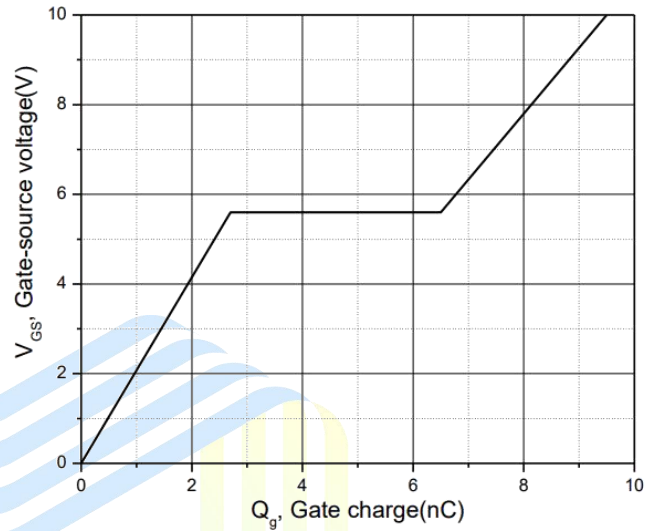
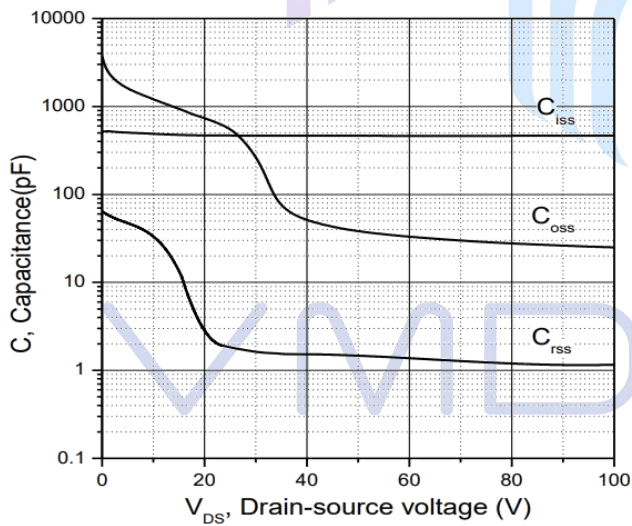
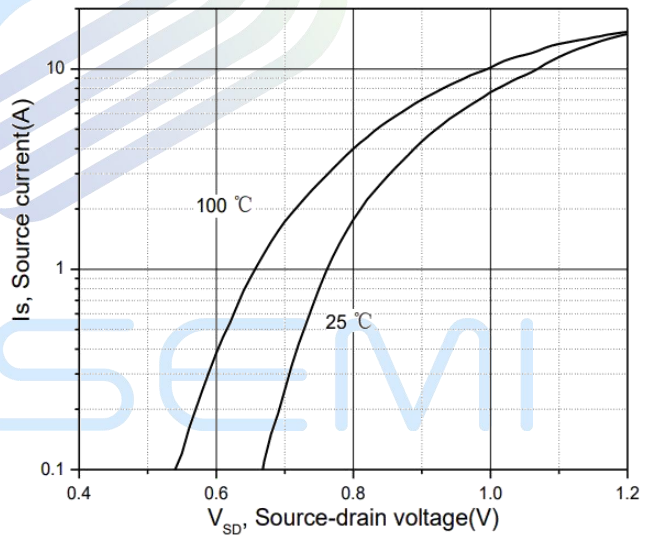
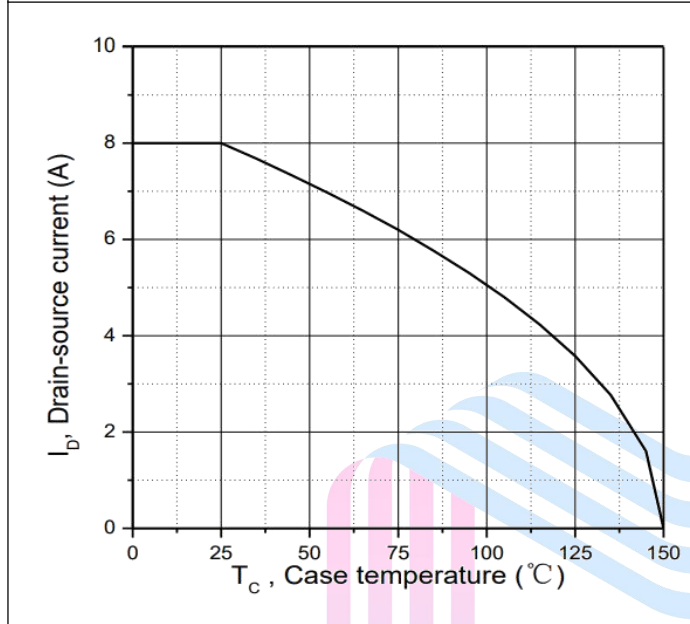
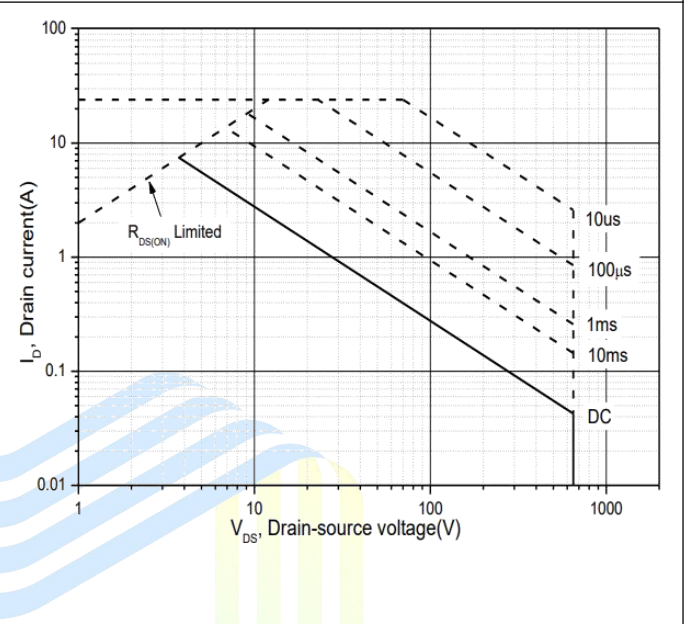
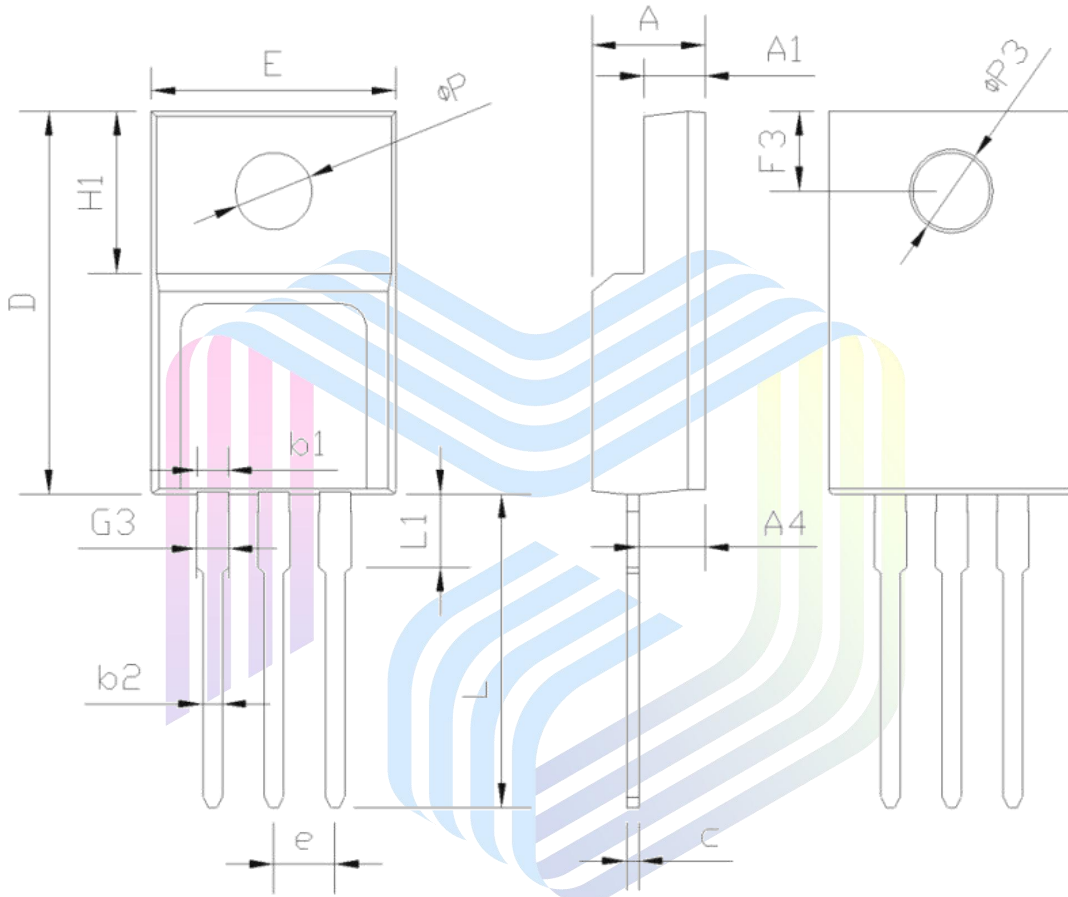
Figure 7: Drain-Source breakdown voltage

Figure 8: Typ. Gate Charge

Figure 9: Typ. Capacitances

Figure 10: Forward Characteristics of Body Diode


Figure 11: Drain Current

Figure 12: Safe Operating Area $T_c=25^\circ\text{C}$



Mechanical Dimensions

Package Information TO220-F



Symbol	Dimensions(mm)			Symbol	Dimensions(mm)		
	Min.	Typ.	Max.		Min.	Typ.	Max.
E	9.96	10.16	10.36	L	12.68	12.98	13.28
A	4.50	4.70	4.90	L1	2.88	3.03	3.18
A1	2.34	2.54	2.74	ΦP	3.03	3.18	3.38
A4	2.56	2.76	2.96	ΦP3	3.15	3.45	3.65
c	0.40	0.50	0.65	F3	3.15	3.30	3.45
D	15.57	15.87	16.17	G3	1.25	1.35	1.55
H1	6.70REF			b1	1.18	1.28	1.43
e	2.54BSC			b2	0.70	0.80	0.95

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